

# XF-PTL05532-F-VI

## 主要参数

|       |                  |
|-------|------------------|
| 光学结构  | 双远心              |
| 倍率    | 0.597            |
| 物方视野  | Φ54.4mm          |
| 像方视野  | Φ32.5mm          |
| 工作距离  | 138mm±3%         |
| 远心度   | <0.04° (0.06°)   |
| 景深    | 1.9-13.2mm       |
| 光圈    | F7.5-F42.2       |
| 分辨力   | 8.3-46.7μm       |
| 像方MTF | >0.3@135-25lp/mm |
| 光学畸变  | <0.060%(0.1%)    |

## 测量范围

|       |           |             |
|-------|-----------|-------------|
| 2'    | 23.0×23.0 | 38.5×38.5mm |
| 7/4'  | 22.5×16.9 | 37.7×28.3mm |
| 4/3'  | 18.0×13.5 | 30.2×22.6mm |
| 1.1'  | 14.2×10.4 | 23.8×17.4mm |
| 1'    | 13.1×8.8  | 21.9×14.7mm |
| 2K线扫描 | 2048×10μm | 34.3mm      |
| 4K线扫描 | 4096×7μm  | 48.0mm      |

